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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Apstron Serial No	
Confirmation No	
Filing Date	August 31, 2000
Inventor	Garo J. Derderian et al.
Assignee	Micron Technology, Inc.
Group Art Unit	2818
Examiner	T. Lee
Customer No	021567
Attorney's Docket No	MI22-1330
Title:Capacitor Fabrication Met	hods Including Forming a Conductive Layer

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Reference -See Attached Form PTO-1449

In compliance with 37 C.F.R. §§ 1.56, 1.97 and 1.98, your attention is directed to the United States patents and other references listed on the attached Form PTO-1449. No admission is made regarding whether all the submitted references are prior art.

Citation of these references is respectfully requested.

Respectfully submitted,

Dated: 16 01+ 2006

By:

Reg. No. 44,854

Form PTO-1449			U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. MI22-1330			SERIAL NO. 09/653,149			
LIST OF ART CITED BY APPLICAN (Use several significations)		IT	APPLICANT:	l Derderi	ian et	: al.					
			4012		THE DATE		Т				
\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\				FILING DATE August 31, 2000			GROUP 2818				
U.S. PATENT DOCUMENTS											
*Examiner's Initials		Document Number	Date	Name		Class	Subclass		Filing Date If Appropriate		
	AA	6,207,561	03/2001	Hwang et al.							
	AB	5,006,956	04/1991	Kawakita et al.							
	AC	6,730,163	05/2004	Vaartstra							
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	AF	7,018,469	03/2006	Li et al.				_			
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·	AJ	5,774,327	06/1998	Park, Soon-oh							
FOREIGN F	ATEN	T DOCUMENTS				· · ·		 -			
		Document Number	Date	Date Country		Class	Subclass		Translation Yes No		
	AJ.					-			res		
	AK				• • •						
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OTHER RE	FEREN	ICES (including Author,	Title, Date, Pe	ertinent Pages, Etc.)		•					
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EXAMINER		DATE CONSIDE	RED		·	···					
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.											